





an Open Access Journal by MDPI

Face Recognition and Its Applications

Guest Editors:

Prof. Dr. Abdelmalik Taleb-Ahmed

Laboratory of IEMN DOAE. UMR CNRS 852, University of Valenciennes, 59313 Valenciennes, France

Prof. Dr. Abdeldjalil Ouahabi UMR 1253, iBrain, Université de

Tours, INSERM, 37000 Tours, France

Deadline for manuscript submissions:

closed (15 August 2021)

Message from the Guest Editors

The human face brings with its appearance and shape a number of clues enabling the extraction of information about person identity, gender, age, ethnicity, health, emotional state and physical wellness, to name but a few. Face recognition has a critical role in biometric systems and is attractive for numerous applications including visual surveillance and security, medical imaging, and affective computing. Vigorous research is needed to solve such outstanding challenging problems and propose advanced solutions and systems for emerging applications of facial image processing and analysis.

Topics of interest include, but are not limited to, the following:

- Face and feature detection
- Pre-processing methods
- New sensors or data sources
- Data set and evaluation
- Machine learning and deep learning
- Applications of face recognition











an Open Access Journal by MDPI

Editor-in-Chief

Prof. Dr. Flavio Canavero

Department of Electronics and Telecommunications, Politecnico di Torino, 10129 Torino, Italy

Message from the Editor-in-Chief

Electronics is a multidisciplinary journal designed to appeal to a diverse audience of research scientists, practitioners, and developers in academia and industry. The journal is devoted to fast publication of latest technological breakthroughs, cutting-edge developments, and timely reviews of current and emerging technologies related to the broad field of electronics. Experimental and theoretical results are published as regular peer-reviewed articles or as articles within Special Issues guest-edited by leading experts in selected topics of interest.

Author Benefits

Open Access: free for readers, with article processing charges (APC) paid by authors or their institutions.

High Visibility: indexed within Scopus, SCIE (Web of Science),

CAPlus / SciFinder, Inspec, and other databases.

Journal Rank: JCR - Q2(Electrical and Electronic Engineering) CiteScore - Q2 (Electrical

and Electronic Engineering

Contact Us